Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/604,289	CHEN ET AL.
Examiner	Art Unit
TUAN A. PHAM	2618

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	575.1	8/16/2006	PHAM
	575.3		
	575.4		
	575.6	8/16/2006	PHAM

INTERFERENCE SEARCHED		
Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
		:		
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